

 Report No.: 18220WC20019104
 FCC ID: XUJCRT701
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FCC SAR Test Report

Client Name : Launch Tech Co., Ltd.

Address Launch Industrial Park, North of Wuhe Rd. Banxuegang, Longgang, Shenzhen, China

Product Name : SMART TPMS DIAGNOSTIC TOOL

Date : Mar. 25, 2022

Shenzhen Anbotek Compliance Laboratory Limited

Shenzhen Anbotek Compliance Laboratory Limited

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Report No.: 18220WC20019104 FCC ID: XUJCRT701 TESTREPORT

Applicant	: Launch Tech Co., Ltd.
Manufacturer	: Launch Tech Co., Ltd.
Product Name	SMART TPMS DIAGNOSTIC TOOL
Model No.	CRT 711, CRT 7xx, CRT 7xxy, CRT 7xxx, CRT 7xxxy ("xx"=01-99, "xxx"=001- 999, "Y"=A~Z)
Trade Mark	LAUNCH :
Rating(s)	Input: AC100-240V,50/60HZ (with DC 3.7V, 6100 mAh Battery inside)

Test Standard(s) : IEC 62209-2:2010; IEEE 1528:2013; FCC 47 CFR Part 2 (2.1093:2013); ANSI/IEEE C95.1:2005; Reference FCC KDB 447498; KDB 248227; KDB 616217

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the IEC 62209-2:2010, IEEE 1528:2013, FCC 47 CFR Part 2 (2.1093:2013), ANSI/IEEE C95.1:2005 and Reference KDB 447498, KDB 248227, KDB 616217 requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Receipt Date of Test

Prepared By

Feb. 16, 2022 Mar. 07~Mar. 08, 2022

Ella Lan

(Ella Liang)

JIN Kingkong

(Kingkong Jin)

Approved & Authorized Signer

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Version No.	Date	Description
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1. Statement of Compliance

The maximum results of Specific Absorption Rate (SAR) found during testing are as follows.

<Highest SAR Summary>

Francisco Daniel	Highest Reported 1g-SAR(W/Kg)	SAR Test Limit
Frequency Band	Body-worn(0mm)	(W/Kg)
WIFI 2.4G	0.761	1.6
WIFI 5.2G	0.580	1.6
WIFI 5.8G	0.502	1.6
Test Result	PASS	Anboro An

This device is in compliance with Specific Absorption Rate (SAR) for general population/uncontrolled exposure limits (1.6 W/kg) specified in KDB 447498 D01 v06, 2015 and ANSI/IEEE C95.1:2005, and had been tested in accordance with the measurement methods and procedures specified in IEEE 1528-2013.

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2. General Information

2.1 Client Information

Applicant	:	Launch Tech Co., Ltd.
Address	:	Launch Industrial Park, North of Wuhe Rd. Banxuegang, Longgang, Shenzhen, China
Manufacturer	:	Launch Tech Co., Ltd.
Address	:	Launch Industrial Park, North of Wuhe Rd. Banxuegang, Longgang, Shenzhen, China
Factory	:	Launch Tech Co., Ltd.
Address	:	Launch Industrial Park, North of Wuhe Rd. Banxuegang, Longgang, Shenzhen, China

2.2 Description of Equipment Under Test (EUT)

Product Name	:	SMART TPMS DIAGNOS	TIC TOOL	
Model No.	:	CRT 711, CRT 7xx, CRT 7 999, "Y"=A~Z)	7xxy, CRT 7xxx, CRT 7xxxy ("xx"=01-99,"xxx"=001-	
Trade Mark	:	(Note:All samples are the same except the model number, appearance color,Key decorative ring color and deagnostic function, sowe prepare "CRT 711"for test only.)		
Test Power Supply	:	LAUNCH	-abolisk Ambolisk Ambolisk Ambolisk	
Test Sample No.	:	1-2-1(Engineering Sample	e) and his	
		Operation Frequency:	WiFi 2.4G: 2412~2462MHz WiFi 5.2G: 5180~5240MHz WiFi 5.8G: 5745~5825MHz SRD:125kHz(Transmit), 433MHz(Receive)	
Product Description	:	Anbolek Anbolek	WiFi 2.4G: 11 Channels for 802.11b/g/ n(HT20) 7 Channels for 802.11n(HT40)	
		Number of Channel:	WiFi 5.2G: 4 Channels for 802.11a/n(HT20)/ac(HT20) 2 Channels for 802.11n(HT40)/ac(HT40) 1 Channel for 802.11ac(HT80)	
		otek subotek A	WiFi 5.8G:	

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	220WC20019104 FCC II	D: XUJCRT701 Page 8 of 85 5 Channels for 802.11a/n(HT20)/ac(HT20) 2 Channels for 802.11n(HT40)/ac(HT40) 1 Channel for 802.11ac(HT80) SRD:2Channels
4 20 3	Modulation Type:	WiFi 2.4G: CCK, DQPSK, DBPSK for DSSS 64QAM, 16QAM, QPSK, BPSK for OFDM WiFi 5G: OFDM with BPSK/QPSK/16QAM/64QAM/256QA SRD:ASK
	Antenna Type:	FPC Antenna
6 0 ⁶	Antenna Gain(Peak):	WiFi 2.4G: 4.9dBi (Provided by customer) WiFi 5G: 5.15dBi (Provided by customer) SRD:0dBi(Provided by customer)

Remark: 1) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

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Product Safety

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2.3 Device Category and SAR Limits

This device belongs to portable device category because its radiating structure is allowed to be used within 20 centimeters of the body of the user. Limit for General Population/Uncontrolled exposure should be applied for this device, it is 1.6 W/kg as averaged over any 1 gram of tissue.

2.4 Applied Standard

The Specific Absorption Rate (SAR) testing specification, method, and procedure for this device is in accordance with the following standards:

IEC 62209-2:2010;

IEEE 1528:2013;

ANSI/IEEE C95.1:2005

FCC 47 CFR Part 2 (2.1093:2013)

Reference FCC KDB 447498; KDB 248227; KDB 616217

2.5 Environment of Test Site

Items	Required	Actual
Temperature (°C)	18-25	22~23
Humidity (%RH)	30-70	55~65

2.6 Test Configuration

For WIFI and Bluetooth SAR testing, engineering testing software installed on the EUT can provide continuous transmitting RF signal.

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2.7 Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 184111

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 184111, September 30, 2020.

ISED-Registration No.: 8058A

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (ISED) Innovation, Science and Economic Development Canada. The acceptance letter from the ISED is maintained in our files. Registration 8058A, September 30, 2020.

Test Location

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3. Specific Absorption Rate (SAR)

3.1 Introduction

SAR is related to the rate at which energy is absorbed per unit mass in an object exposed to a radio field. The SAR distribution in a biological body is complicated and is usually carried out by experimental techniques or numerical modeling. The standard recommends limits for two tiers of groups, occupational/controlled and general population/uncontrolled, based on a person's awareness and ability to exercise control over his or her exposure. In general, occupational/controlled exposure limits are higher than the limits for general population/uncontrolled.

3.2 SAR Definition

The SAR definition is the time derivative (rate) of the incremental energy (dW) absorbed by (dissipated in) an incremental mass (dm) contained in a volume element (dv) of a given density (ρ).The equation description is as below:

$$SAR = \frac{d}{dt} \left(\frac{dW}{dm} \right) = \frac{d}{dt} \left(\frac{dW}{\rho dv} \right)$$

SAR is expressed in units of Watts per kilogram (W/kg)

SAR measurement can be either related to the temperature elevation in tissue by

$$\mathbf{SAR} = \mathbf{C}\left(\frac{\mathbf{\delta T}}{\mathbf{\delta t}}\right)$$

Where: C is the specific head capacity, δT is the temperature rise and δ tisthe exposure duration, or related to the electrical field in the tissue by

$$SAR = \frac{\sigma |E|^2}{\rho}$$

Where: σ is the conductivity of the tissue, ρ is the mass density of the tissue and E is the RMS electrical field strength.

However for evaluating SAR of low power transmitter, electrical field measurement is typically applied.

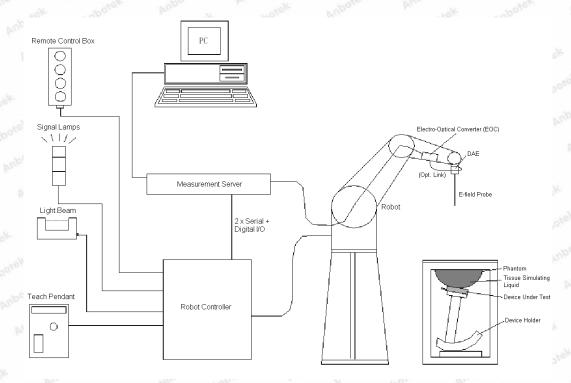
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4. SAR Measurement System



DASY System Configurations

The DASY system for performance compliance tests is illustrated above graphically. This system consists of the following items:

- > A standard high precision 6-axis robot with controller, a teach pendant and software
- > A data acquisition electronic (DAE) attached to the robot arm extension
- > A dosimetric probe equipped with an optical surface detector system
- The electro-optical converter (EOC) performs the conversion between optical and electrical signals
- A measurement server performs the time critical tasks such as signal filtering, control of the robot operation and fast movement interrupts.
- > A probe alignment unit which improves the accuracy of the probe positioning
- A computer operating Windows XP
- DASY software
- Remove control with teach pendant and additional circuitry for robot safety such as warming lamps, etc.
- The SAM twin phantom
- A device holder
- Tissue simulating liquid
- Dipole for evaluating the proper functioning of the system

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Report No.: 18220WC20019104FCC ID: XUJCRT701components are described in details in the following sub-sections.

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4.1 E-Field Probe

The SAR measurement is conducted with the dosimetric probe (manufactured by SPEAG). The probe is specially designed and calibrated for use in liquid with high permittivity. The dosimetric probe has special calibration in liquid at different frequency. This probe has a built in optical surface detection system to prevent from collision with phantom.

<ex3dv4 probe<="" th=""><th>he will mother Are</th><th>.teh</th><th>enbo.</th><th>20</th></ex3dv4>	he will mother Are	.teh	enbo.	20
Construction	Symmetrical design with triangular core Built-in shielding against static charges PEEK enclosure material (resistant to organic solvents, e.g., DGBE)		7	2006 24
Frequency	10 MHz to 6 GHz; Linearity: ± 0.2 dB		2.1	
Directivity	 ± 0.3 dB in HSL (rotation around probe axis) ± 0.5 dB in tissue material (rotation normal to probe axis) 	Aupi A		pot Ant
Dynamic Range	10 μW/g to 100 mW/g; Linearity: ± 0.2 dB (noise: typically < 1 μW/g)	otek	T	
Dimensions	Overall length: 330 mm (Tip: 20 mm) Tip diameter: 2.5 mm (Body: 12 mm) Typical distance from probe tip to dipole centers: 1 mm	Photo	of EX3DV4	Anbotek Anbote

E-Field Probe Specification

E-Field Probe Calibration

Each probe needs to be calibrated according to a dosimetric assessment procedure with accuracy better than \pm 10%. The spherical isotropy shall be evaluated and within \pm 0.25dB. The sensitivity parameters (NormX, NormY, and NormZ), the diode compression parameter (DCP) and the conversion factor (ConvF) of the probe are tested. The calibration data can be referred to appendix C of this report.

4. 2 Data Acquisition Electronics (DAE)

The data acquisition electronics (DAE) consists of a highly sensitive electrometer-grade preamplifier with auto-zeroing, a channel and gain-switching multiplexer, a fast 16 bit AD-converter and a command decoder and control logic unit. Transmission to the measurement server is accomplished through an optical downlink for data and status information as well as an optical uplink for commands and the clock.

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The input impedance of the DAE is 200MOhm; the inputs are symmetrical and floating. Common mode rejection is above 80dB.



Photo of DAE

4. 3 **Robot**

The SPEAG DASY system uses the high precision robots (DASY5: TX60XL) type from Stäubli SA (France). For the 6-axis controller system, the robot controller version (DASY5: CS8c) from Stäubli is used. The Stäubli robot series have many features that are important for our application:

- > High precision (repeatability ±0.035 mm)
- High reliability (industrial design)
- Jerk-free straight movements
- > Low ELF interference (the closed metallic construction shields against motor control fields)



Photo of DASY5

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4. 4 Measurement Server

The measurement server is based on a PC/104 CPU board with CPU (DASY5: 400 MHz, Intel Celeron), chip disk (DASY5: 128 MB), RAM (DASY5: 128 MB). The necessary circuits for communication with the DAE electronic box, as well as the 16 bit AD converter system for optical detection and digital I/O interface are contained on the DASY I/O board, which is directly connected to the PC/104 bus of the CPU board.

The measurement server performs all the real-time data evaluation for field measurements and surface detection, controls robot movements and handles safety operations.



Photo of Server for DASY5

4.5 Phantom

<SAM Twin Phantom>

Shell Thickness	2 ± 0.2 mm;	And Her Know
	Center ear point: 6 ± 0.2 mm	
Filling Volume	Approx. 25 liters	CT. THE
Dimensions	Length: 1000 mm; Width: 500 mm;	
	Height: adjustable feet	
Measurement	Left Hand, Right Hand, Flat	
Areas	Phantom	
	not subohek Antrone	
	Anthony All Jorek Anthones	1

Photo of SAM Phantom

The bottom plate contains three pair of bolts for locking the device holder. The device holder positions are adjusted to the standard measurement positions in the three sections. A white cover is provided to tap the phantom during off-periods to prevent water evaporation and changes in the liquid parameters. On the phantom top, three reference markers are provided to identify the phantom position with respect to the robot.

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Photo of ELI4 Phantom

The ELI4 phantom is intended for compliance testing of handheld and body-mounted wireless devices in the frequency range of 30 MHz to 6 GHz. ELI4 is fully compatible with standard and all known tissue simulating liquids.

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4.6 Device Holder

The SAR in the phantom is approximately inversely proportional to the square of the distance between the source and the liquid surface. For a source at 5 mm distance, a positioning uncertainty of ± 0.5 mm would produce a SAR uncertainty of $\pm 20\%$. Accurate device positioning is therefore crucial for accurate and repeatable measurements. The positions in which the devices must be measured are defined by the standards.

The DASY device holder is designed to cope with different positions given in the standard. It has two scales for the device rotation (with respect to the body axis) and the device inclination (with respect to the line between the ear reference points). The rotation center for both scales is the ear reference point (ERP). Thus the device needs no repositioning when changing the angles.

The DASY device holder is constructed of low-loss POM material having the following dielectric parameters: relative permittivity ε = 3 and loss tangent δ = 0.02. The amount of dielectric material has been reduced in the closest vicinity of the device, since measurements have suggested that the influence of the clamp on the test results could thus be lowered.





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4.7 Data Storage and Evaluation

Data Storage

The DASY software stores the assessed data from the data acquisition electronics as raw data (in microvolt readings from the probe sensors), together with all the necessary software parameters for the data evaluation (probe calibration data, liquid parameters and device frequency and modulation data) in measurement files. The post-processing software evaluates the desired unit and format for output each time the data is visualized or exported. This allows verification of the complete software setup even after the measurement and allows correction of erroneous parameter settings. For example, if a measurement has been performed with an incorrect crest factor parameter in the device setup, the parameter can be corrected afterwards and the data can be reevaluated.

The measured data can be visualized or exported in different units or formats, depending on the selected probe type (e.g., [V/m], [A/m], [mW/g]). Some of these units are not available in certain situations or give meaningless results, e.g., a SAR-output in a non-lose media, will always be zero. Raw data can also be exported to perform the evaluation with other software packages.

Data Evaluation

The DASY post-processing software (SEMCAD) automatically executes the following procedures to calculate the field units from the microvolt readings at the probe connector. The parameters used in the evaluation are stored in the configuration modules of the software:

Probe parameters:	- Sensitivity	Normi, ai0, ai1,	ai
	- Conversion factor	ConvFi	
	- Diode compression point	t dcp _i	
Device parameters:	- Frequency	f Amber and	
	- Crest factor	cf	
Media parameters:	- Conductivity	^N σ μηθοτο	
	- Density	P ¹	

These parameters must be set correctly in the software. They can be found in the component documents or they can be imported into the software from the configuration files issued for the DASY components. In the direct measuring mode of the multi-meter option, the parameters of the actual system setup are used. In the scan visualization and export modes, the parameters stored in the corresponding document files are used.

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly

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The formula for each channel can be given as:

$$V_i = U_i + U_i^2 \cdot \frac{cf}{dcp}$$

with V_i = compensated signal of channel i, (i = x, y, z)

 U_i = input signal of channel i, (i = x, y, z)

cf = crest factor of exciting field (DASY parameter)

dcp_i = diode compression point (DASY parameter)

From the compensated input signals, the primary field data for each channel can be evaluated:

E-field Probes:
$$E_i = \sqrt{\frac{V_i}{Norm_i \cdot ConvF}}$$

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H-field Probes: $H_i = \sqrt{V_i} \cdot \frac{a_{i0} + a_{i1}f + a_{i2}f^2}{f}$

with V_i = compensated signal of channel i,(i = x, y, z)

Norm_i= sensor sensitivity of channel i, (i = x, y, z), $\mu V/(V/m)^2$ for E-field Probes

ConvF= sensitivity enhancement in solution

aij= sensor sensitivity factors for H-field probes

f = carrier frequency [GHz]

E_i= electric field strength of channel i in V/m

H_i= magnetic field strength of channel i in A/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$\mathbf{E}_{tot} = \sqrt{\mathbf{E}_x^2 + \mathbf{E}_y^2 + \mathbf{E}_z^2}$$

The primary field data are used to calculate the derived field units.

$$SAR = E_{tot}^2 \cdot \frac{\sigma}{\rho \cdot 1000}$$

with SAR = local specific absorption rate in mW/g

Etot= total field strength in V/m

 σ = conductivity in [mho/m] or [Siemens/m]

 ρ = equivalent tissue density in g/cm³

Note that the density is set to 1, to account for actual head tissue density rather than the density of the tissue simulating liquid.

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5. Test Equipment List

Monufacturer	Nome of Equipment	Turne/Media	Carial Number	Calib	ration
Manufacturer	Name of Equipment	Type/Model	Serial Number	Last Cal.	Due Date
SPEAG	5GHz System Validation Kit D5GHzV2		1160	Oct. 02, 2021	Oct. 01, 2024
SPEAG	2450MHz System Validation Kit	D2450V2	910	Jun. 15,2021	Jun. 14,2024
SPEAG	SPEAG Data Acquisition Electronics		387	Sept.06,2021	Sept.05,2022
SPEAG	Dosimetric E-Field Probe	EX3DV4	7396	May 06,2021	May 05,2022
Agilent	ENA Series Network Analyzer	E5071C	MY46317418	Oct.26, 2021	Oct.25, 2022
SPEAG	DAK	DAK-3.5	1226	NCR	NCR
SPEAG	ELI Phantom	QDOVA004AA	2058	NCR	NCR
AR	Amplifier	ZHL-42W	QA1118004	NCR	NCR
Agilent	Power Meter	N1914A	MY50001102	Oct.26, 2021	Oct.25, 2022
Agilent	Power Sensor	N8481H	MY51240001	Oct.26, 2021	Oct.25, 2022
R&S	Spectrum Analyzer	N9020A	MY51170037	Oct.26, 2021	Oct.25, 2022
Agilent	Agilent Signal Generation		MY48180656	Oct.26, 2021	Oct.25, 2022
Worken	Directional Coupler	0110A05601O-10	COM5BNW1A2	Oct.26, 2021	Oct.25, 2022

Note:

1. The calibration certificate of DASY can be referred to appendix C of this report.

- 2. The dipole calibration interval can be extended to 3 years with justification. The dipoles are also not physically damaged, or repaired during the interval.
- 3. The Insertion Loss calibration of Dual Directional Coupler and Attenuator were characterized via the network analyzer and compensated during system check.
- 4. The dielectric probe kit was calibrated via the network analyzer, with the specified procedure (calibrated in pure water) and calibration kit (standard) short circuit, before the dielectric measurement. The specific procedure and calibration kit are provided by Agilent.
- 5. In system check we need to monitor the level on the power meter, and adjust the power amplifier level to have precise power level to the dipole; the measured SAR will be normalized to 1W input power according to the ratio of 1W to the input power to the dipole. For system check, the calibration of the power amplifier is deemed not critically required for correct measurement; the power meter is critical and we do have calibration for it

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6. Tissue Simulating Liquids

For the measurement of the field distribution inside the SAM phantom with DASY, the phantom must be filled with around 25 liters of homogeneous body tissue simulating liquid. For head SAR testing, the liquid height from the ear reference point (ERP) of the phantom to the liquid top surface is larger than 15 cm, which is shown in Fig. 6.1. For body SAR testing, the liquid height from the center of the flat phantom to the liquid top surface is larger than 15 cm, which is shown as followed:



Photo of Liquid Height for Body SAR

Frequency (MHz)	Water (%)	Sugar (%)	Cellulose (%)	Salt (%)	Prevento I (%)	DGBE (%)	Conductivity (σ)	Permittivity (εr)
				For Bo	dy			
2450	68.6	0	0	0	31.4	0	1.95	52.7
5200	78.6	0	10.7	0	10.7	0	5.27	49.0
5800	78.5	0 000	10.8	0	10.7	0	6.00	48.2

The following table gives the recipes for tissue simulating liquid.

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Report No.: 18220WC20019104FCC ID: XUJCRT701Page 22 of 85The following table shows the measuring results for simulating liquid.

	Measured	Target	Tissue		Measure	d Tissue)	Liquid Temp.(°C)		
Tissue Type	Frequenc y (MHz)	٤r	σ	٤r	Dev. (%)	σ	Dev. (%)		Test Date	
2450MSL	2450	52.7	1.95	51.88	1.56%	1.87	4.10%	21.7	03/08/2022	
5200MSL	5200	49.0	5.27	48.55	0.92%	5.32	-0.95%	22.4	03/07/2022	
5800MSL	5800	48.2	6.0	49.3	-2.28%	5.82	3.00%	23.3	03/07/2022	

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7. System Verification Procedures

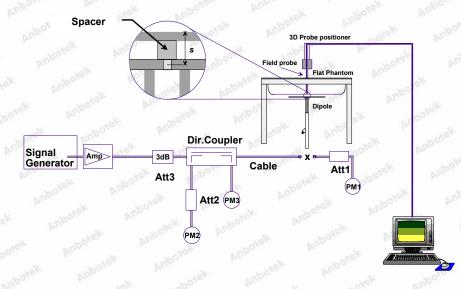
Each DASY system is equipped with one or more system validation kits. These units, together with the predefined measurement procedures within the DASY software, enable the user to conduct the system performance check and system validation. System validation kit includes a dipole, tripod holder to fix it underneath the flat phantom and a corresponding distance holder.

> Purpose of System Performance check

The system performance check verifies that the system operates within its specifications. System and operator errors can be detected and corrected. It is recommended that the system performance check be performed prior to any usage of the system in order to guarantee reproducible results. The system performance check uses normal SAR measurements in a simplified setup with a well characterized source. This setup was selected to give a high sensitivity to all parameters that might fail or vary over time. The system check does not intend to replace the calibration of the components, but indicates situations where the system uncertainty is exceeded due to drift or failure.

System Setup

In the simplified setup for system evaluation, the EUT is replaced by a calibrated dipole and the power source is replaced by a continuous wave that comes from a signal generator. The calibrated dipole must be placed beneath the flat phantom section of the SAM twin phantom with the correct distance holder. The distance holder should touch the phantom surface with a light pressure at the reference marking and be oriented parallel to the long side of the phantom. The equipment setup is shown below:



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Photo of Dipole Setup

Validation Results

Comparing to the original SAR value provided by SPEAG, the verification data should be within its specification of 10%. The table below shows the target SAR and measured SAR after normalized to 1W input power. It indicates that the system performance check can meet the variation criterion and the plots can be referred to Appendix A of this report.

Frequenc y (MHz)	Liquid Type	Power fed onto reference dipole (mW)	Targeted SAR (W/kg)	Measured SAR (W/kg)	Normalized SAR (W/kg)	Deviatio n (%)	Test Date
2450	Body	250	51.8	12.85	51.4	-0.77	03/08/2022
5200	Body	100	77.8	7.61	76.1	-2.19	03/07/2022
5800	Body	100	78.3	7.83	78.3	0.00	03/07/2022

Target and Measurement SAR after Normalized

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8. EUT Testing Position

8.1 Body Worn Position

motherd tela

Body-worn operating configurations are tested with the belt-clips and holsters attached to the device and positioned against a flat phantom in a normal use configuration. Per KDB 648474 D04, bodyworn accessory exposure is typically related to voice mode operations when handsets are carried in body-worn accessories. The body-worn accessory procedures in FCC KDB 447498 D01 v06, 2015 should be used to test for body-worn accessory SAR compliance, without a headset connected to it. This enables the test results for such configuration to be compatible with that required for hotspot mode when the body-worn accessory test separation distance is greater than or equal to that required for hotspot mode, when applicable. When the reported SAR for body-worn accessory, measured without a headset connected to the handset is < 1.2 W/kg, the highest reported SAR configuration for that wireless mode and frequency band should be repeated for that body-worn accessory with a handset attached to the handset.

Accessories for body-worn operation configurations are divided into two categories: those that do not contain metallic components and those that do contain metallic components. When multiple accessories that do not contain metallic components are supplied with the device, the device is tested with only the accessory that dictates the closest spacing to the body. Then multiple accessories that contain metallic components are test with the device with each accessory. If multiple accessories share an identical metallic component (i.e. the same metallic belt-chip used with different holsters with no other metallic components) only the accessory that dictates the closest spacing to the body is tested.

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Body Worn Position

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9. Measurement Procedures

The measurement procedures are as follows:

- (a) Use base station simulator (if applicable) or engineering software to transmit RF power continuously (continuous Tx) in the middle channel.
- (b) Keep EUT to radiate maximum output power or 100% duty factor (if applicable)
- (c) Measure output power through RF cable and power meter.
- (d) Place the EUT in the positions as setup photos demonstrates.
- (e) Set scan area, grid size and other setting on the DASY software.
- (f) Measure SAR transmitting at the middle channel for all applicable exposure positions.
- (g) Identify the exposure position and device configuration resulting the highest SAR
- (h) Measure SAR at the lowest and highest channels at the worst exposure position and device configuration if applicable.

According to the test standard, the recommended procedure for assessing the peak spatial-average SAR value consists of the following steps:

- (a) Power reference measurement
- (b) Area scan
- (c) Zoom scan
- (d) Power drift measurement

9.1 Spatial Peak SAR Evaluation

The procedure for spatial peak SAR evaluation has been implemented according to the test standard. It can be conducted for 1g and 10g, as well as for user-specific masses. The DASY software includes all numerical procedures necessary to evaluate the spatial peak SAR value.

The base for the evaluation is a "cube" measurement. The measured volume must include the 1g and 10g cubes with the highest averaged SAR values. For that purpose, the center of the measured volume is aligned to the interpolated peak SAR value of a previously performed area scan.

The entire evaluation of the spatial peak values is performed within the post-processing engine (SEMCAD). The system always gives the maximum values for the 1g and 10g cubes. The algorithm to find the cube with highest averaged SAR is divided into the following stages:

- (a) Extraction of the measured data (grid and values) from the Zoom Scan
- (b) Calculation of the SAR value at every measurement point based on all stored data (A/D values and measurement parameters)
- (c) Generation of a high-resolution mesh within the measured volume
- (d) Interpolation of all measured values form the measurement grid to the high-resolution grid
- (e) Extrapolation of the entire 3-D field distribution to the phantom surface over the distance from

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(f) Calculation of the averaged SAR within masses of 1g and 10g

9.2 Power Reference Measurement

The Power Reference Measurement and Power Drift Measurements are for monitoring the power drift of the device under test in the batch process. The minimum distance of probe sensors to surface determines the closest measurement point to phantom surface. This distance cannot be smaller than the distance of sensor calibration points to probe tip as defined in the probe properties.

9.3 Area Scan Procedures

The area scan is used as a fast scan in two dimensions to find the area of high field values, before doing a fine measurement around the hot spot. The sophisticated interpolation routines implemented in DASY software can find the maximum found in the scanned area, within a range of the global maximum. The range (in dB0 is specified in the standards for compliance testing. For example, a 2 dB range is required in IEEE standard 1528 and IEC 62209 standards, whereby 3 dB is a requirement when compliance is assessed in accordance with the ARIB standard (Japan), if only one zoom scan follows the area scan, then only the absolute maximum will be taken as reference. For cases where multiple maximums are detected, the number of zoom scans has to be increased accordingly.

Area scan parameters extracted from FCC KDB 865664 D01 SAR measurement 100 MHz to 6 GHz.

	\leq 3 GHz	> 3 GHz
Maximum distance from closest measurement point (geometric center of probe sensors) to phantom surface	$5 \pm 1 \text{ mm}$	$\frac{1}{2} \cdot \delta \cdot \ln(2) \pm 0.5 \text{ mm}$
Maximum probe angle from probe axis to phantom surface normal at the measurement location	$30^{\circ}\pm1^{\circ}$	$20^\circ\pm1^\circ$
	≤2 GHz: ≤15 mm 2 – 3 GHz: ≤12 mm	3 – 4 GHz: ≤ 12 mm 4 – 6 GHz: ≤ 10 mm
Maximum area scan spatial resolution: Δx_{Area} , Δy_{Area}	When the x or y dimension o measurement plane orientation the measurement resolution r x or y dimension of the test d measurement point on the test	on, is smaller than the above, must be \leq the corresponding evice with at least one

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9. 4 Zoom Scan Procedures

Zoom scans are used assess the peak spatial SAR values within a cubic averaging volume containing 1 gram and 10gram of simulated tissue. The zoom scan measures points (refer to table below) within a cube shoes base faces are centered on the maxima found in a preceding area scan job within the same procedure. When the measurement is done, the zoom scan evaluates the averaged SAR for 1 gram and 10 gram and displays these values next to the job's label. Zoom scan parameters extracted from FCC KDB 865664 D01 SAR measurement 100 MHz to 6 GHz.

	244	55 · · · · · · · · · · · · · · · · · ·	≤ 3 GHz	> 3 GHz
provide and the second	F 65	po nak	"pole" Nue	n conten and
Maximum zoom scan s	patial reso	olution: $\Delta x_{Zoom}, \Delta y_{Zoom}$	≤ 2 GHz: ≤ 8 mm 2 - 3 GHz: ≤ 5 mm [*]	$3 - 4 \text{ GHz} \le 5 \text{ mm}^*$ $4 - 6 \text{ GHz} \le 4 \text{ mm}^*$
	uniform	grid: ∆z _{Zoom} (n)	\leq 5 mm	3 – 4 GHz: ≤ 4 mm 4 – 5 GHz: ≤ 3 mm 5 – 6 GHz: ≤ 2 mm
Maximum zoom scan spatial resolution, normal to phantom surface	graded	$\Delta z_{Zoom}(1)$: between 1 st two points closest to phantom surface	\leq 4 mm	3 – 4 GHz: ≤ 3 mm 4 – 5 GHz: ≤ 2.5 mm 5 – 6 GHz: ≤ 2 mm
	grid	Δz _{Zoom} (n>1): between subsequent points	$\leq 1.5 \cdot \Delta$	z _{Zoom} (n-1)
Minimum zoom scan rolume	x, y, z		\geq 30 mm	3 – 4 GHz; ≥ 28 mm 4 – 5 GHz; ≥ 25 mm 5 – 6 GHz; ≥ 22 mm

Note: δ is the penetration depth of a plane-wave at normal incidence to the tissue medium; see draft standard IEEE P1528-2011 for details.

When zoom scan is required and the <u>reported</u> SAR from the area scan based 1-g SAR estimation procedures of KDB 447498 is \leq 1.4 W/kg, \leq 8 mm, \leq 7 mm and \leq 5 mm zoom scan resolution may be applied, respectively, for 2 GHz to 3 GHz, 3 GHz to 4 GHz and 4 GHz to 6 GHz.

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9.5 Volume Scan Procedures

The volume scan is used for assess overlapping SAR distributions for antennas transmitting in different frequency bands. It is equivalent to an oversized zoom scan used in standalone measurements. The measurement volume will be used to enclose all the simultaneous transmitting antennas. For antennas transmitting simultaneously in different frequency bands, the volume scan is measured separately in each frequency band. In order to sum correctly to compute the 1g aggregate SAR, the EUT remain in the same test position for all measurements and all volume scan use the same spatial resolution and grid spacing. When all volume scan were completed, the software, SEMCAD postprocessor can combine and subsequently superpose these measurement data to calculating the multiband SAR.

9.6 Power Drift Monitoring

All SAR testing is under the EUT install full charged battery and transmit maximum output power. In DASY measurement software, the power reference measurement and power drift measurement procedures are used for monitoring the power drift of EUT during SAR test. Both these procedures measure the field at a specified reference position before and after the SAR testing. The software will calculate the field difference in dB. If the power drift more than 5%, the SAR will be retested.

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10. Conducted Power

Mode	Channel	Frequen cy (MHz)	Peak Power (dBm)	Average Power(dBm)	Tune-Up Limit(dBm)	Test Rate Data
	-nb ^o 1	2412	13.97	13.35	14.00	1 Mbps
802.11 b	6	2437	14.04	13.57	14.00	1 Mbps
	11	2462	14.33	13.62	14.00	1 Mbps
	1 ^{mb}	2412	15.29	13.15	13.50	6 Mbps
802.11 g	6 M ²⁵	2437	15.18	13.08	13.50	6 Mbps
	11	2462	15.33	13.17	13.50	6 Mbps
	1	2412	15.47	12.85	13.00	MCS0
802.11 n(HT20)	6	2437	15.18	12.59	13.00	MCS0
11(1120)	11	2462	15.66	12.97	13.00	MCS0
	3 poter	2422	13.05	10.73	11.00	MCS0
802.11 n(HT40)	6	2437	13.05	10.78	11.00	MCS0
11(11140)	9	2452	13.26	10.85	11.00	MCS0

<WIFI 2.4GHz Conducted Power>

Note:

- 1. Per KDB 447498 D01 v06, the test distance less than 5mm
- 2. Per KDB 248227 D01, choose the highest output power channel to test SAR and determine further SAR exclusion.
- 3. Per KDB 248227 D01, In the 2.4 GHz band, separate SAR procedures are applied to DSSS and OFDM configurations to simplify DSSS test requirements. SAR is not required for the following 2.4 GHz OFDM conditions:
 - 1) When KDB Publication 447498 SAR test exclusion applies to the OFDM configuration.
 - 2) When the highest reported SAR for DSSS is adjusted by the ratio of OFDM to DSSS specified maximum output power and the adjusted SAR is \leq 1.2 W/kg.

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Tune-Up Average **Test Rate** TestMode Channel Power[dBm] Limit(dBm) Data 5180 12.59 14.00 6M 5200 14.00 6M 11.66 11A 5240 13.74 14.00 6M 5180 11.97 12.00 MCS0 11N20 5200 11.65 12.00 MCS0 5240 12.00 MCS0 10.77 5190 11.82 12.00 MCS0 11N40 5230 11.01 12.00 MCS0 5180 11.89 12.00 MCS0 5200 12.00 MCS0 11AC20 11.50 5240 10.78 12.00 MCS0 5190 11.66 12.00 MCS0 11AC40 5230 12.00 MCS0 11.07 5210 12.50 MCS0 11AC80 12.17

Band 4

TestMode	Channel	Average Power[dBm]	Tune-Up Limit(dBm)	Test Rate Data
And wat	5745	11.31	11.50	6M
11A	5785	10.92	11.50	6M
	5825	11.03	11.50	6M
otek subotek	5745	11.24	11.50	MCS0
11N20	5785	11.02	11.50	MCS0
	5825	11.15	11.50	MCS0
Anbon	5755	11.40	11.50	MCS0
11N40	5795	11.13	11.50	MCS0
4 Anboten	5745	11.19	11.50	MCS0
11AC20	5785	10.94	11.50	MCS0
	5825	10.80	11.50	MCS0
44.6.40	5755	11.23	11.50	MCS0
11AC40	5795	11.24	11.50	MCS0
11AC80	5775	11.80	12.00	MCS0

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1. Per KDB 447498 D02 v02r01, the test distance less than 5mm

2. Per KDB 248227 D01, choose the highest output power channel to test SAR and determine further SAR exclusion.

3. Per KDB 248227 D01, In the 5 GHz band, separate SAR procedures are applied to DSSS and OFDM configurations to simplify DSSS test requirements. SAR is not required for the following 5 GHz OFDM conditions:

1) When KDB Publication 447498 SAR test exclusion applies to the OFDM configuration.

2) When the highest reported SAR for DSSS is adjusted by the ratio of OFDM to DSSS specified maximum output power and the adjusted SAR is \leq 1.2 W/kg.

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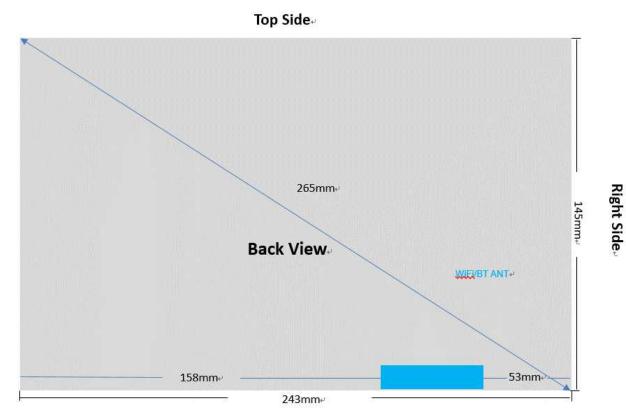




Left Side.

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11. Antenna Location



Bottom Side.

Thickness: 34mm

EUT BACK VIEW

Distance of The Antenna to the EUT surface and edge										
Antennas Front Back Top Side Bottom Side Left Side Right Side										
WiFi ANT <25mm										

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SAR Test Results Summary 12.

General Note:

- Per KDB 447498 D01 v06, the reported SAR is the measured SAR value adjusted for maximum 1. tune-up tolerance.
 - Scaling Factor = tune-up limit power (mW) / EUT RF power (mW), where tune-up limit is the maximum rated power among all production units.

Reported SAR(W/kg)= Measured SAR(W/kg) Scaling Factor* 2. Per KDB 447498 D01 v06, for each exposure position, if the highest output channel reported SAR≤0.8W/kg, other channels SAR testing are not necessary

Plot No.	Band	Mode	Test Position	Gap (cm)		Freq. (MHz)	е	Tune- Up Limit (dBm)	Scalin g Factor	r Drift	Measure d SAR _{1g} (W/kg)	Reporte d SAR _{1g} (W/kg)
1	WIFI 2.4GHz	802.11g	Back	0	11	2462	13.62	14.00	1.091	-0.07	0.379	0.414
#1	WIFI 2.4GHz	802.11g	Front	0	11	2462	13.62	14.00	1.091	0.05	0.697	0.761
of del	WIFI 2.4GHz	802.11g	Right	0	11	2462	13.62	14.00	1.091	N/A	N/A	N/A
abotol	WIFI 2.4GHz	802.11g	🗠 Left	0	11	2462	13.62	14.00	1.091	N/A	N/A	N/A
	WIFI 2.4GHz	802.11g	Тор	0	11	2462	13.62	14.00	1.091	N/A	N/A	N/A
Par.	WIFI 2.4GHz	802.11g	Bottom	0	11	2462	13.62	14.00	1.091	0.16	0.644	0.703

Plot No.	Band	Mode	Test Position	Gap (cm)		Freq. (MHz)	е	Up Limit	Scalin g Factor	r Drift	Measure d SAR _{1g} (W/kg)	Reporte d SAR _{1g} (W/kg)
Pur	WIFI 5.2GHz	802.11a	Back	0	48	5240	13.74	14.00	1.062	-0.05	0.265	0.281
#2	WIFI 5.2GHz	802.11a	Front	0	48	5240	13.74	14.00	1.062	-0.08	0.546	0.580
	WIFI 5.2GHz	802.11a	Right	0	48	5240	13.74	14.00	1.062	N/A	N/A	N/A
10	WIFI 5.2GHz	802.11a	Left	0	48	5240	13.74	14.00	1.062	N/A	N/A	N/A
. Not	WIFI 5.2GHz	802.11a	Тор	0	48	5240	13.74	14.00	1.062	N/A	N/A	N/A
	WIFI 5.2GHz	802.11a	Bottom	0	48	5240	13.74	14.00	1.062	0.07	0.528	0.561

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Plot No.	Band	Mode	Test Position	Gap (cm)		Freq. (MHz)	е	Tune- Up Limit (dBm)	Scalin g Factor	r Drift	Measure d SAR _{1g} (W/kg)	Reporte d SAR _{1g} (W/kg)
Anbot	WIFI 5.8GHz	802.11ac (HT80)	Back	0	155	5775	11.80	12.00	1.047	0.16	0.157	0.164
#3	WIFI 5.8GHz	802.11ac (HT80)	Front	0	155	5775	11.80	12.00	1.047	0.09	0.479	0.502
ptek	WIFI 5.8GHz	802.11ac (HT80)	Right	0	155	5775	11.80	12.00	1.047	N/A	N/A	N/A
Anbore	WIFI 5.8GHz	802.11ac (HT80)	Left	0	155	5775	11.80	12.00	1.047	N/A	N/A	N/A
Po.	WIFI 5.8GHz	802.11ac (HT80)	Тор	0.000	155	5775	11.80	12.00	1.047	N/A	N/A	N/A
a de	WIFI 5.8GHz	802.11c (HT80)	Bottom	0	155	5775	11.80	12.00	1.047	-0.07	0.461	0.483

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13. Measurement Uncertainty

NO	Source	Uncert. ai (%)	Prob. Dist.	Div. k	ci (1g)	ci (10g)	Stand.U ncert. ui (1g)	Stand.U ncert. ui (10g)	Veff 9
1	Repeat	0.4	N	1	1	1	0.4	0.4	9
p.	obotek Anboto, A	nu wotelt	Instru	iment	Aupo.	dt m	obotek	Anboto	Am
2	Probe calibration	7 _{botel}	N pobo	2	1	1	3.5	3.5	∞
3	Axial isotropy	4.7	R v.		0.7	0.7	1.9	1.9	
4 ₂₄	Hemispherical isotropy	9.4	R	√3 √3	0.7	0.7	3.9	3.9	×***
5	Boundary effect	1.0	R R	√3	10	otek 1	0.6	0.6	∞
6	Linearity	4.7	R	√3	Nex 1	Pi ^{bot}	2.7	2.7	ø
Ambu 7 Am	Detection limits	1.0	R	√3	nboton 110	1 1	0.6	0.6	00
8	Readout electronics	0.3	N	1	1	1	0.3	0.3	^{10¹} ∞ 1
9	Response time	0.8	potek R	√3	1	1,01	0.5	0.5	8
10	Integration time	2.6	Rie	√3	tootek 1	1 Ant	1.5	1.5	∞
11	Ambient noise	3.0	R	√3	Anbone Alor	^{nek} 1	1.7	1.7	on 10
12	Ambient reflections	3.0	o ^{stelk} R	√3	1	hoten lote	1.7	1.7	∞
13	Probe positioner mech. restrictions	0.4	Rob	√3	potek 1 Anbotek	1	0.2	0.2	Achotek Achotek

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eport I	No.: 18220WC2001910)4	FCC ID	XUJC	RT70	1	N Built	Page 37	of 85
14	Probe positioning with respect to phantom shell	2.9	R	√3	ootek Anbolek	Ant Ant	1.7	1.7	8
15	Max.SAR evaluation	1.0	R		Anbo 1 _{bi}	botek 1	0.6	0.6	~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~

by	nbotek Anboton A	anbotek	Test samp	le rela	ted	jok pi	Anbotek	Anbotek	Anbur K Anb
16	Device positioning	3.8	hek N hr	00 ¹⁰¹	1 55	ootek 1.otek	3.8	3.8	99
17	Device holder	5.1	hbotek N	Anbon 1 Ant	oto ^y 1	1,00	5.1	5.1	5
18	Drift of output power	5.0	R	√3	1001	1	2.9	2.9	8
8-1 	Anborn Antonek	Anboter	Phantom a	and se	t-up	optek	Anbon	sk sob	of Note
19	Phantom uncertainty	4.0	R R	√3	1	Anboter 1,bot	2.3	2.3	∞. ¹
20	Liquid conductivity (target)	5.0	Rout	√3	0.64	0.43	1.8	1.2	kabotak Mabotak
21	Liquid conductivity (meas)	2.5	N	otek 1 obotek	0.64	0.43	1.6	1.2	8
22	Liquid Permittivity (target)	5.0	R R	√3	0.6	0.49	1.7	1.5	8
23	Liquid Permittivity (meas)	2.5	N N	5 ¹⁰ 1	0.6	0.49	1.5	1.2	8
botok Anbotr Anb	Combined standard	e Ant otek nbotek	RSS	" U	$c = \sum_{i=1}^{n} C_i l$	J _{2ⁱ 2}	11.4%	11.3%	236
und	Expanded certainty(P=95%)	Anbor	ľ	$J_c = k U$,k=2	2 potek	22.8%	22.6%	otok Ant

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Report No.: 18220WC20019104FCC ID: XUJCRT701Page 38 of 85Appendix A.EUT Photos and Test Setup Photos



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Appendix B. Plots of SAR System Check

2450MHz Body System Check

Date:03/08/2022

DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN:910 Communication System: UID 0, CW; Frequency: 2450 MHz;Duty Cycle: 1:1 Medium parameters used: f = 2450 MHz; σ = 1.87 S/m; ϵ_r = 51.88; ρ = 1000 kg/m³ Phantom section: Flat Section

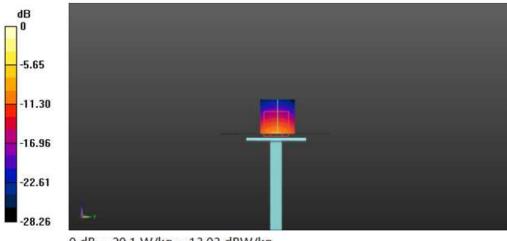
DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(7.53, 7.53, 7.53); Calibrated: May 06, 2021;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: Sep. 06, 2021
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Configuration/Pin=250mW/Area Scan (81x81x1): Interpolated grid: dx=1.200 mm, dy=1.200 mm Maximum value of SAR (interpolated) = 20.6 W/kg

Configuration/Pin=250mW/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 88.387 V/m; Power Drift = 0.07 dB Peak SAR (extrapolated) = 26.6 W/kg SAR(1 g) = 12.85 W/kg; SAR(10 g) = 5.87W/kg Maximum value of SAR (measured) = 20.1 W/kg



0 dB = 20.1 W/kg = 13.03 dBW/kg

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Anbotek Product Safety

Report No.: 18220WC20019104FCC ID: XUJCRT7015200MHz Body System CheckDUT: Dipole 5GHz; Type: D5GHzV2; Serial: D5GHzV2 - SN:1160

Communication System: UID 0, CW; Frequency: 5200 MHz; Duty Cycle: 1:1 Medium parameters used: f = 5200 MHz; σ = 5.32 S/m; ϵ_r = 48.55; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(4.93, 4.93, 4.93); Calibrated: May 06, 2021;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: Sep. 06, 2021
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Configuration/Pin=100mW/Area Scan (71x71x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm Maximum value of SAR (interpolated) = 20.2 W/kg

Configuration/Pin=100mW/Zoom Scan (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm

Reference Value = 58.761 V/m; Power Drift = -0.06 dB Peak SAR (extrapolated) = 33.9 W/kg SAR(1 g) = 7.61 W/kg; SAR(10 g) = 2.26 W/kg Maximum value of SAR (measured) = 20.7 W/kg



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Date:03/07/2022



FCC ID: XUJCRT701

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5800MHz Body System Check

DUT: Dipole 5800 MHz; Type: D5GHzV2; Serial: D5GHzV2 - SN:1160

Communication System: UID 0, CW; Frequency: 5800 MHz;Duty Cycle: 1:1 Medium parameters used: f = 5800 MHz; σ = 5.82 S/m; ϵ_r = 49.30; ρ = 1000 kg/m³ Phantom section: Flat Section

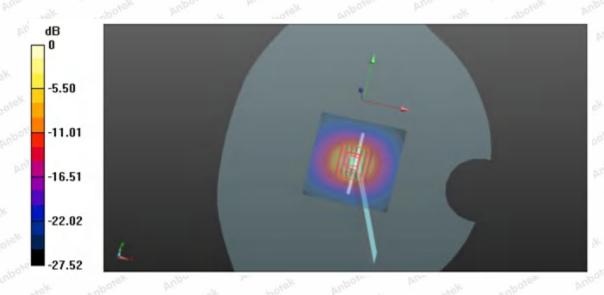
DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(4.52, 4.52, 4.52); Calibrated: May 06, 2021;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: Sep. 06, 2021
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

Configuration/Pin=100mW/Area Scan (71x71x1): Interpolated grid: dx=1.000 mm, dy=1.000 mm Maximum value of SAR (interpolated) = 18.7 W/kg

Configuration/Pin=100mW/Zoom Scan (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm,

dz=1.4mm Reference Value = 56.113 V/m; Power Drift = 0.05 dB Peak SAR (extrapolated) = 31.8 W/kg SAR(1 g) = 7.83 W/kg; SAR(10 g) = 2.16 W/kg Maximum value of SAR (measured) = 19.6 W/kg



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Anbotek Product Safety

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Appendix C. Plots of SAR Test Data

#1

Date: 03/08/2022

2.4G WIFI_802.11B_CH11 BODY FRONT

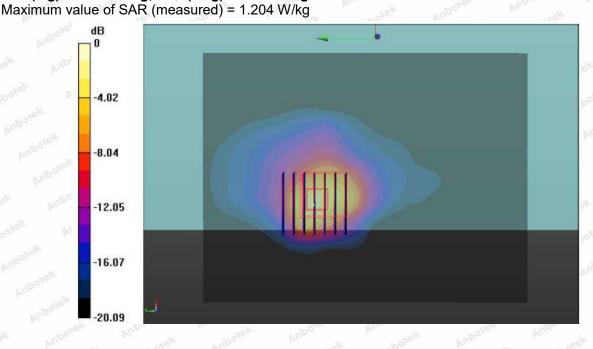
Communication System: UID 0, wifi (fcc) (0); Frequency: 2462 MHz;Duty Cycle: 1:1 Medium parameters used (interpolated): f = 2462 MHz; σ = 1.87 S/m; ϵ_r = 51.88; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(7.53, 7.53, 7.53); Calibrated: May 06, 2021;
- Sensor-Surface: 1.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: Sep. 06, 2021
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

BODY FRONT/Area Scan (141x121x1): Interpolated grid: dx=1.200 mm, dy=1.200 mm Maximum value of SAR (interpolated) = 1.235 W/kg

BODY FRONT/Zoom Scan (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm Reference Value = 1.733 V/m; Power Drift = 0.05 dB Peak SAR (extrapolated) = 1.221 W/kg SAR(1 g) = 0.697 W/kg; SAR(10 g) = 0.355W/kg



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Report No.: 18220WC20019104 FCC **#2**

FCC ID: XUJCRT701

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WIFI 5.2G_802.11A_CH48 BODY FRONT

Communication System: UID 0, wifi (fcc) (0); Frequency: 5240 MHz;Duty Cycle: 1:1 Medium parameters used (interpolated): f = 5240 MHz; σ = 5.43 S/m; ϵ_r = 48.56; ρ = 1000 kg/m³ Phantom section: Flat Section

DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(4.93, 4.93, 4.93); Calibrated: May 06, 2021;
- Sensor-Surface: 1.4mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: Sep. 06, 2021
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

BODY FRONT /Area Scan (121x161x1): Measurement grid: dx=1.000mm, dy=1.000mm Maximum value of SAR (interpolated) = 0.995 W/kg

BODY FRONT /Zoom Scan (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 1.247 V/m; Power Drift = -0.08 dB Peak SAR (extrapolated) = 0.951 W/kg SAR(1 g) = 0.546W/kg; SAR(10 g) = 0.319W/kg Maximum value of SAR (measured) = 0.989 W/kg



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Report No.: 18220WC20019104 FCC ID: XUJCRT701 #3

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WIFI 5.8G_802.11AC(HT80)_CH155 BODY FRONT

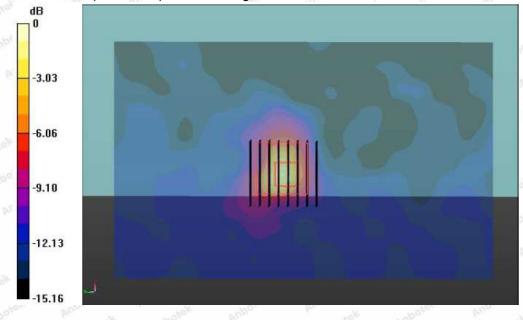
Communication System: UID 0, wifi (fcc) (0); Frequency: 5775 MHz; Duty Cycle: 1:1 Medium parameters used (interpolated): f = 5775 MHz; σ = 5.82 S/m; ϵ r = 49.3; ρ = 1000 kg/m3 Phantom section: Flat Section

DASY5 Configuration:

- Probe: EX3DV4 SN7396; ConvF(4.52, 4.52, 4.52); Calibrated: May 06, 2021;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn387; Calibrated: Sep. 06, 2021
- Phantom: SAM; Type: QD000P40CD; Serial: TP:1670
- Measurement SW: DASY52, Version 52.8 (2); SEMCAD X Version 14.6.10 (7164)

BODY FRONT /Area Scan (121x161x1): Measurement grid: dx=1.000mm, dy=1.000mm Maximum value of SAR (measured) = 0.841W/kg

BODY FRONT /Zoom Scan (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 1.087 V/m; Power Drift = 0.09 dB Peak SAR (extrapolated) = 0.814 W/kg SAR(1 g) = 0.479 W/kg; SAR(10 g) = 0.279 W/kg Maximum value of SAR (measured) = 0.827 W/kg



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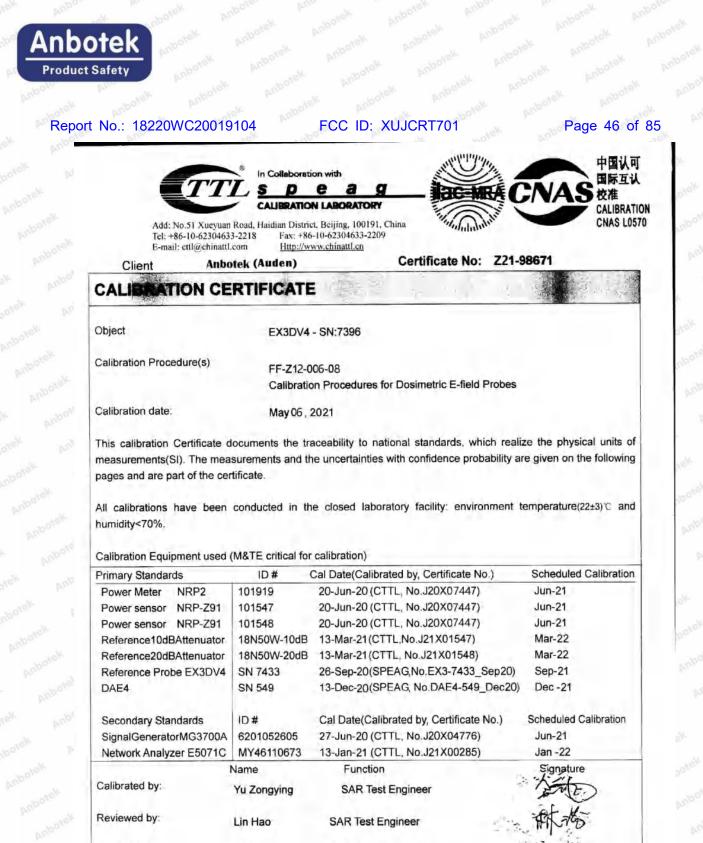
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Appendix D. DASY System Calibration Certificate

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Approved by:

Issued: May06, 2021

This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

Certificate No: Z21-98671

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SAR Project Leader

Shenzhen Anbotek Compliance Laboratory Limited

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Qi Dianyuan



FCC ID: XUJCRT701





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 Http://www.chinattl.com

Glossary:

TSL	tissue simulating liquid
NORMx,y,z	sensitivity in free space
ConvF	sensitivity in TSL / NORMx,y,z
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A,B,C,D	modulation dependent linearization parameters
Polarization Φ	Φ rotation around probe axis
Polarization 0	θ rotation around an axis that is in the plane normal to probe axis (at measurement center), i θ=0 is normal to probe axis

Connector Angle information used in DASY system to align probe sensor X to the robot coordinate system Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) for hand-held devices used in close proximity to the ear (frequency range of 300MHz to 3GHz)", February 2005
- c) IEC 62209-2, "Procedure to determine the Specific Absorption Rate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)", March 2010

d) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Methods Applied and Interpretation of Parameters:

- NORMx, y, z: Assessed for E-field polarization θ=0 (f≤900MHz in TEM-cell; f>1800MHz: waveguide). NORMx, y, z are only intermediate values, i.e., the uncertainties of NORMx, y, z does not effect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)x, y,z = NORMx, y,z* frequency_response (see Frequency Response Chart). This
 linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the
 frequency response is included in the stated uncertainty of ConvF.
- DCPx, y, z: DCP are numerical linearization parameters assessed based on the data of power sweep (no uncertainty required). DCP does not depend on frequency nor media.
- PAR: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics.
- Ax,y,z; Bx,y,z; Cx,y,z; VRx,y,z;A,B,C are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters: Assessed in flat phantom using E-field (or Temperature Transfer Standard for f≤800MHz) and inside waveguide using analytical field distributions based on power measurements for f >800MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty valued are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORMx,y,z* ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from±50MHz to±100MHz.
- Spherical isotropy (3D deviation from isotropy): in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset: The sensor offset corresponds to the offset of virtual measurement center from the
 probe tip (on probe axis). No tolerance required.
- Connector Angle: The angle is assessed using the information gained by determining the NORMx (no uncertainty required).

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In Collaboration with s D е а g CALIBRATION LABORATORY

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Probe EX3DV4

SN: 7396

Calibrated: May 06, 2021

Calibrated for DASY/EASY Systems

(Note: non-compatible with DASY2 system!)

Certificate No: Z21-98671

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DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

g

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k=2)
Norm(µV/(V/m) ²) ^A	0.54	0.53	0.50	±10.0%
DCP(mV) ^B	97.8	104.5	102.5	

Modulation Calibration Parameters

UID	Communication System Name		A dB	B dBõV	С	D dB	VR mV	Unc ^E (k=2)
0 CW	CW	X	0.0	0.0	1.0	0.00	199.9	±2.4%
		Y	0.0	0.0	1.0		203.3	
		Z	0.0	0.0	1.0		195.0	

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor k=2, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

^A The uncertainties of Norm X, Y, Z do not affect the E²-field uncertainty inside TSL (see Page 5 and Page 6). ^B Numerical linearization parameter: uncertainty not required.

^E Uncertainly is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

Certificate No: Z21-98671

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DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Calibration Parameter Determined in Head Tissue Simulating Media

f [MHz] ^C	Relative Permittivity ^F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unct. (k=2)
750	41.9	0.89	9.82	9.82	9.82	0.30	0.85	±12.1%
835	41.5	0.90	9.71	9.71	9.71	0.15	1.36	±12.1%
900	41.5	0.97	9.87	9.87	9.87	0.16	1.37	±12.1%
1750	40.1	1.37	8.61	8.61	8.61	0.25	1.04	±12.1%
1900	40.0	1.40	8.13	8.13	8.13	0.24	1.01	±12.1%
2100	39.8	1.49	8.14	8.14	8.14	0.24	1.04	±12.1%
2300	39.5	1.67	7.85	7.85	7.85	0.40	0.75	±12.1%
2450	39.2	1.80	7.57	7.57	7.57	0.50	0.75	±12.1%
2600	39.0	1.96	7.38	7.38	7.38	0.64	0.68	±12.1%
5250	35.9	4.71	5.33	5.33	5.33	0.45	1.30	±13.3%
5600	35.5	5.07	4.89	4.89	4.89	0.45	1.35	±13.3%
5750	35.4	5.22	4.92	4.92	4.92	0.45	1.45	±13.3%

^c Frequency validity above 300 MHz of ±100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to ±50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

^F At frequency below 3 GHz, the validity of tissue parameters (ϵ and σ) can be relaxed to ±10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ϵ and σ) is restricted to ±5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters. ^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary

effect after compensation is always less than \pm 1% for frequencies below 3 GHz and below \pm 2% for the frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.

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 E-mail: ettl@chinattl.com
 <u>Http://www.chinattl.cn</u>

DASY/EASY – Parameters of Probe: EX3DV4 – SN: 7396

Calibration Parameter Determined in Body Tissue Simulating Media

f [MHz] ^C	Relative Permittivity ^F	Conductivity (S/m) ^F	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unct. (k=2)
750	55.5	0.96	10.09	10.09	10.09	0.30	0.90	±12.1%
835	55.2	0.97	9.88	9.88	9.88	0.19	1.32	±12.1%
900	55.0	1.05	9,82	9.82	9.82	0.23	1.15	±12.1%
1750	53.4	1.49	8.24	8.24	8.24	0.24	1.06	±12.1%
1900	53.3	1.52	7.97	7.97	7.97	0.19	1.24	±12.1%
2100	53.2	1.62	8.18	8.18	8.18	0.19	1.39	±12.1%
2300	52.9	1.81	7.88	7.88	7.88	0.55	0.80	±12.1%
2450	52.7	1.95	7.53	7.53	7.53	0.46	0.89	±12.1%
2600	52.5	2.16	7.38	7.38	7.38	0.52	0.80	±12.1%
5250	48.9	5.36	4.93	4.93	4.93	0.45	1.80	±13.3%
5600	48.5	5.77	4.19	4.19	4.19	0.48	1.90	±13.3%
5750	48.3	5.94	4.52	4.52	4.52	0.48	1.95	±13.3%

^C Frequency validity above 300 MHz of ±100MHz only applies for DASY v4.4 and higher (Page 2), else it is restricted to ±50MHz. The uncertainty is the RSS of ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ± 10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Above 5 GHz frequency validity can be extended to ± 110 MHz.

^F At frequency below 3 GHz, the validity of tissue parameters (ϵ and σ) can be relaxed to ±10% if liquid compensation formula is applied to measured SAR values. At frequencies above 3 GHz, the validity of tissue parameters (ϵ and σ) is restricted to ±5%. The uncertainty is the RSS of the ConvF uncertainty for indicated target tissue parameters.

^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than \pm 1% for frequencies below 3 GHz and below \pm 2% for the frequencies between 3-6 GHz at any distance larger than half the probe tip diameter from the boundary.

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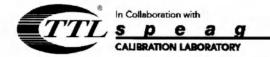
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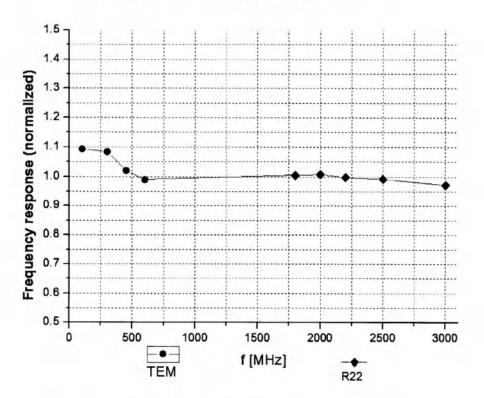


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Frequency Response of E-Field (TEM-Cell: ifi110 EXX, Waveguide: R22)



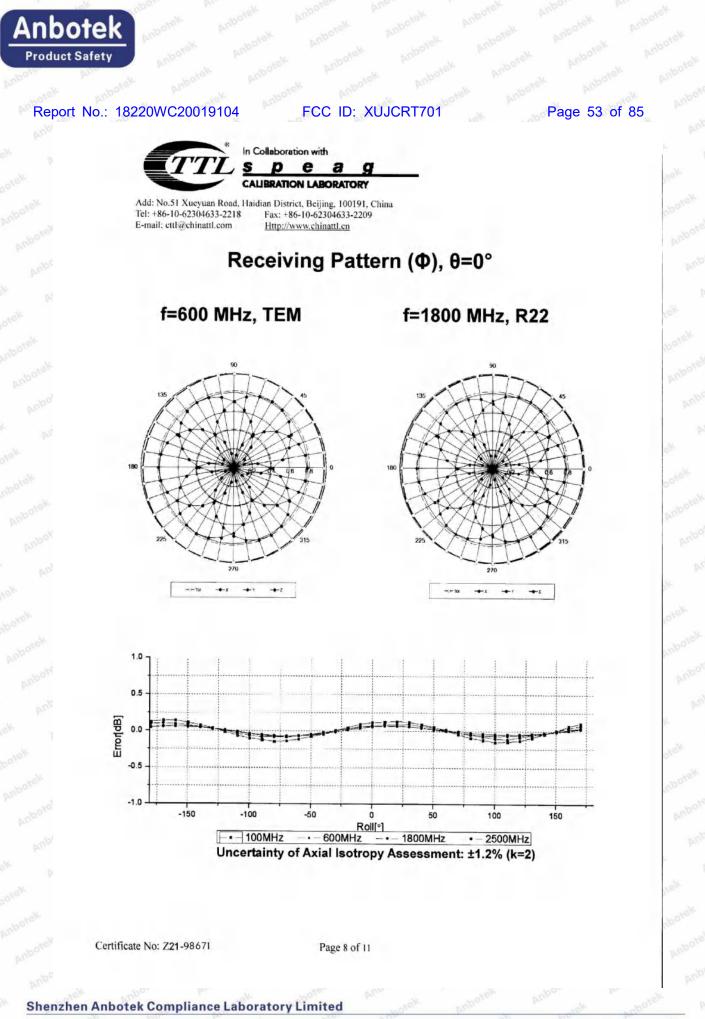
Uncertainty of Frequency Response of E-field: ±7.4% (k=2)

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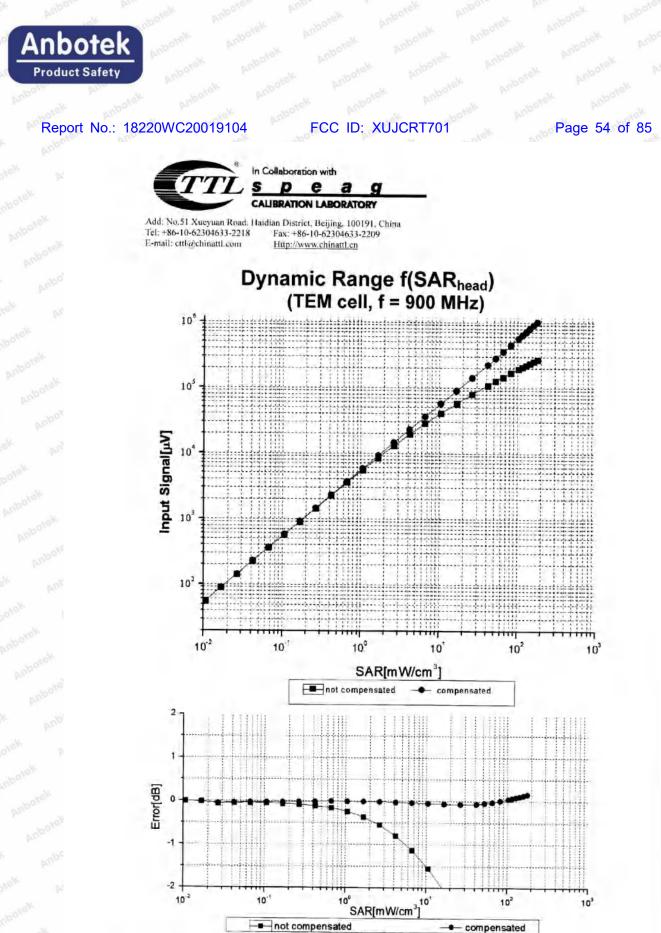
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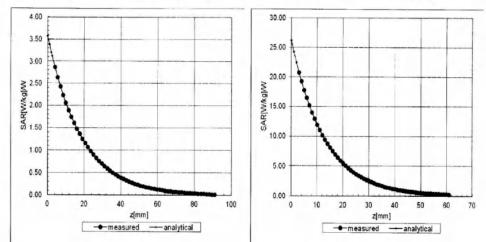
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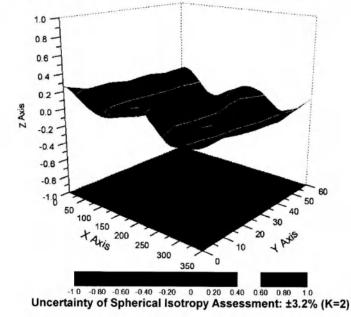
Conversion Factor Assessment

f=900 MHz, WGLS R9(H_convF)

f=1750 MHz, WGLS R22(H_convF)



Deviation from Isotropy in Liquid



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DASY/EASY - Parameters of Probe: EX3DV4 - SN: 7396

Other Probe Parameters

Sensor Arrangement	Triangular
Connector Angle (°)	156.9
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disable
Probe Overall Length	337mm
Probe Body Diameter	10mm
Tip Length	9mm
Tip Diameter	2.5mm
Probe Tip to Sensor X Calibration Point	1mm
Probe Tip to Sensor Y Calibration Point	1mm
Probe Tip to Sensor Z Calibration Point	1mm
Recommended Measurement Distance from Surface	1.4mm

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Schmid & Partner Engineering AG

speag

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IMPORTANT NOTICE

USAGE OF THE DAE 4

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention shall be given to the following points:

Battery Exchange: The battery cover of the DAE4 unit is closed using a screw, over tightening the screw may cause the threads inside the DAE to wear out.

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration, remove the batteries and pack the DAE in an antistatic bag. This antistatic bag shall then be packed into a larger box or container which protects the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, the customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the annual calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

DASY Configuration Files: Since the exact values of the DAE input resistances, as measured during the calibration procedure of a DAE unit, are not used by the DASY software, a nominal value of 200 MOhm is given in the corresponding configuration file.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the Estop assembly is allowed by certified SPEAG personnel only and is part of the annual calibration procedure.

Important Note:

To prevent damage of the DAE probe connector pins, use great care when installing the probe to the DAE. Carefully connect the probe with the connector notch oriented in the mating position. Avoid any rotational movement of the probe body versus the DAE while turning the locking nut of the connector. The same care shall be used when disconnecting the probe from the DAE.

Schmid & Partner Engineering

TN_BR040315AD DAE4.doc

11.12.2009

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Calibration Laboratory of Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



S C S

Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Client Anbotek (Auden)

Certificate No: DAE4-387_Sep10

Accreditation No.: SCS 0108

ject	DAE4 - SD 000 D	04 BM - SN: 387					
ibration procedure(s)	ure(s) QA CAL-06.v29 Calibration procedure for the data acquisition electronics (DAE)						
	Calibration proced	dure for the data acquisition elec	ctronics (DAE)				
bration date:	September 06, 20	21					
calibration certificate docum measurements and the unce	nents the traceability to natio ertainties with confidence pro	nal standards, which realize the physical ur obability are given on the following pages ar	nits of measurements (SI). Ind are part of the certificate.				
alibrations have been condu	cted in the closed laboratory	r facility: environment temperature $(22 \pm 3)^{\circ}$	C and humidity < 70%.				
bration Equipment used (M&	TE critical for calibration)						
	TE critical for calibration)	Cal Date (Certificate No.)	Scheduled Calibration				
ary Standards		Cal Date (Certificate No.) 15-Aug-20 (No:21092)	Scheduled Calibration Aug-21				
ary Standards nley Multimeter Type 2001	ID #						
ary Standards ley Multimeter Type 2001 Indary Standards DAE Calibration Unit	ID # SN: 0810278 ID # SE UWS 053 AA 1001	15-Aug-20 (No:21092) Check Date (in house) 05-Jan-21 (in house check)	Aug-21				
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hery Standards hery Multimeter Type 2001 ondary Standards DAE Calibration Unit orator Box V2.1	ID # SN: 0810278 ID # SE UWS 053 AA 1001 SE UMS 006 AA 1002	15-Aug-20 (No:21092) Check Date (in house) 05-Jan-21 (in house check) 05-Jan-21 (in house check)	Aug-21 Scheduled Check In house check: Jan-22 In house check: Jan-22				

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Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary

DAE Connector angle data acquisition electronics information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a
 result from the performance test and require no uncertainty.
 - DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
 - Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
 - AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
 - Input Offset Measurement: Output voltage and statistical results over a large number of zero voltage measurements.
 - Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - Input resistance: Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
 - Power consumption: Typical value for information. Supply currents in various operating modes.

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DC Voltage Measurement

A/D - Converter	Resolution	nominal	
-----------------	------------	---------	--

Calibration Factors	x	Y	z
High Range	404.489 ± 0.02% (k=2)	404.852 ± 0.02% (k=2)	404.862 ± 0.02% (k=2)
		3.95875 ± 1.50% (k=2)	

Connector Angle

Connector Angle to be used in DASY system	53.0 ° ± 1 °
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Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range	Reading (µV)	Difference (µV)	Error (%)
Channel X + Input	200032.85	-3.31	-0.00
Channel X + Input	20007.64	1.88	0.01
Channel X - Input	-20003.48	1.18	-0.01
Channel Y + Input	200034.23	-1.43	-0.00
Channel Y + Input	20006.60	0.91	0.00
Channel Y - Input	-20004.04	0.72	-0.00
Channel Z + Input	200035.38	-0.83	-0.00
Channel Z + Input	20003.69	-2.11	-0.01
Channel Z - Input	-20006.38	-1.59	0.01

Low Range	Reading (µV)	Difference (µV)	Error (%)
Channel X + Input	2001.63	0.08	0.00
Channel X + Input	202.29	0.70	0.35
Channel X - Input	-197.90	0.60	-0.30
Channel Y + Input	2001.33	-0.07	-0.00
Channel Y + Input	200.86	-0.60	-0.30
Channel Y - Input	-199.87	-1.23	0.62
Channel Z + Input	2001.61	0.27	0.01
Channel Z + Input	200.60	-0.70	-0.35
Channel Z - Input	-199.51	-0.85	0.43

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (µV)
Channel X	200	13.50	11.56
	- 200	-8.64	-11.18
Channel Y	200	-0.81	-1.28
	- 200	1.05	0.09
Channel Z	200	7.17	6.91
	- 200	-9.46	-9.01

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (µV)	Channel Y (µV)	Channel Z (µV)
Channel X	200	-	-1.70	0.33
Channel Y	200	10.70	-	-0.38
Channel Z	200	7.11	7.89	

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4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15969	17466
Channel Y	15661	16162
Channel Z	15990	16190

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec Input 10M $\!\Omega$

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (µV)
Channel X	0.73	-2.58	3.29	0.62
Channel Y	0.41	-0.49	1.23	0.40
Channel Z	-0.80	-1.88	0.30	0.42

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)	
Supply (+ Vcc)	+7.9	
Supply (- Vcc)	-7.6	

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9

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Glossary: TSL ConvF N/A

tissue simulating liquid sensitivity in TSL / NORMx,y,z not applicable or not measured

In Collaboration with

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- b) IEC 62209-1, "Procedure to measure the Specific Absorption Rate (SAR) For hand-held devices used in close proximity to the ear (frequency range of 300MHz to 3GHz)", February 2005
- c) IEC 62209-2, "Procedure to measure the Specific Absorption Rate (SAR) For wireless communication devices used in close proximity to the human body (frequency range of 30MHz to 6GHz)", March 2010
- d) KDB865664, SAR Measurement Requirements for 100 MHz to 6 GHz

Additional Documentation:

e) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end
 of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed
 point exactly below the center marking of the flat phantom section, with the arms oriented
 parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole
 positioned under the liquid filled phantom. The impedance stated is transformed from the
 measurement at the SMA connector to the feed point. The Return Loss ensures low
 reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of Measurement multiplied by the coverage factor k=2, which for a normal distribution Corresponds to a coverage probability of approximately 95%.

Certificate No: Z21-97091

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Measurement Conditions

DASY system configuration, as far as not given on page 1. **DASY Version** 52.8.8.1258 DASY52 Extrapolation Advanced Extrapolation Phantom Triple Flat Phantom 5.1C **Distance Dipole Center - TSL** 10 mm with Spacer Zoom Scan Resolution dx, dy, dz = 5 mmFrequency 2450 MHz ± 1 MHz

Head TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	39.2	1.80 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	39.0 ± 6 %	1.77 mho/m ± 6 %
Head TSL temperature change during test	<1.0 °C		

SAR result with Head TSL

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	250 mW input power	13.0 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	52.4 mW /g ± 20.8 % (k=2)
SAR averaged over 10 cm^3 (10 g) of Head TSL	Condition	
SAR measured	250 mW input power	6.06 mW / g
SAR for nominal Head TSL parameters	normalized to 1W	24.3 mW /g ± 20.4 % (k=2)

Body TSL parameters

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	52.7	1.95 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	52.9±6%	1.97 mho/m ± 6 %
Body TSL temperature change during test	<1.0 °C		++++

SAR result with Body TSL

SAR averaged over 1 cm^3 (1 g) of Body TSL	Condition	
SAR measured	250 mW input power	13.0 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	51.8 mW /g ± 20.8 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Body TSL	Condition	
SAR measured	250 mW input power	6.18 mW / g
SAR for nominal Body TSL parameters	normalized to 1W	24.7 mW /g ± 20.4 % (k=2)

Certificate No: Z21-97091

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Appendix

Antenna Parameters with Head TSL

Impedance, transformed to feed point	54.6Ω+ 2.77jΩ	
Return Loss	- 25.8dB	

Antenna Parameters with Body TSL

Impedance, transformed to feed point	50.7Ω+ 4.28jΩ	
Return Loss	- 27.3dB	

General Antenna Parameters and Design

Electrical Delay (one direction)	1.263 ns
Electrical Delay (one direction)	1.263 r

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG

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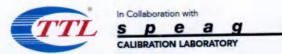
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DASY5 Validation Report for Head TSL

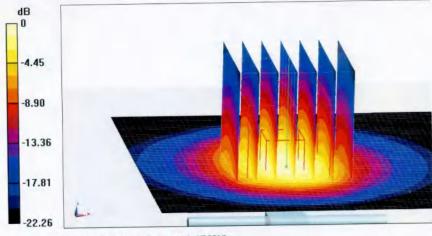
Date: 06.15.2021

Test Laboratory: CTTL, Beijing, China **DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN: 910** Communication System: UID 0, CW; Frequency: 2450 MHz; Duty Cycle: 1:1 Medium parameters used: f = 2450 MHz; $\sigma = 1.767$ S/m; $\epsilon r = 39.01$; $\rho = 1000$ kg/m3 Phantom section: Right Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007) DASY5 Configuration:

- Probe: EX3DV4 SN7307; ConvF(7.36, 7.36, 7.36); Calibrated: 2/19/2021;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn771; Calibrated: 2021-02-02
- Phantom: Triple Flat Phantom 5.1C; Type: QD 000 P51 CA; Serial: 1161/1
- Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7372)

Dipole Calibration/Zoom Scan (7x7x7) (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 106.5 V/m; Power Drift = 0.02 dB Peak SAR (extrapolated) = 26.7 W/kg SAR(1 g) = 13 W/kg; SAR(10 g) = 6.06 W/kg Maximum value of SAR (measured) = 19.7 W/kg



0 dB = 19.7 W/kg = 12.94 dBW/kg

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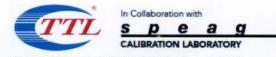
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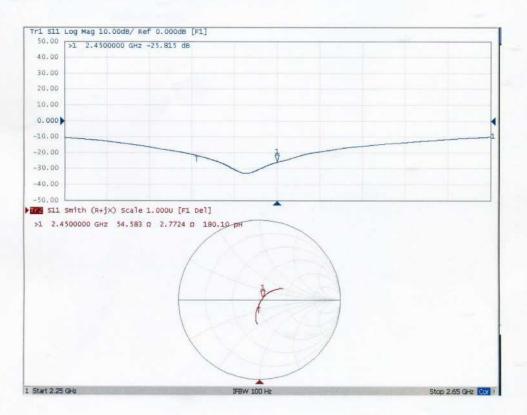
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Impedance Measurement Plot for Head TSL



Certificate No: Z21-97091

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 Http://www.chinattl.cn

DASY5 Validation Report for Body TSL Test Laboratory: CTTL, Beijing, China

Date: 06.15.2021

DUT: Dipole 2450 MHz; Type: D2450V2; Serial: D2450V2 - SN: 910 Communication System: UID 0, CW; Frequency: 2450 MHz; Duty Cycle: 1:1 Medium parameters used: f = 2450 MHz; $\sigma = 1.972$ S/m; $\epsilon_r = 52.92$; $\rho = 1000$ kg/m³ Phantom section: Center Section Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2007)

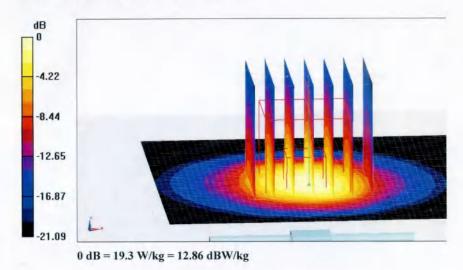
DASY5 Configuration:

- Probe: EX3DV4 SN7307; ConvF(7.22, 7.22, 7.22); Calibrated: 2/19/2021;
- Sensor-Surface: 2mm (Mechanical Surface Detection)
- Electronics: DAE4 Sn771; Calibrated: 2021-02-02
- Phantom: Triple Flat Phantom 5.1C; Type: QD 000 P51 CA; Serial: 1161/1
- Measurement SW: DASY52, Version 52.8 (8); SEMCAD X Version 14.6.10 (7372)

Dipole Calibration/Zoom Scan (7x7x7) (7x7x7)/Cube 0: Measurement grid: dx=5mm, dy=5mm, dz=5mm

Reference Value = 98.89 V/m; Power Drift = 0.03 dBPeak SAR (extrapolated) = 25.6 W/kgSAR(1 g) = 13 W/kg; SAR(10 g) = 6.18 W/kg

Maximum value of SAR (measured) = 19.3 W/kg



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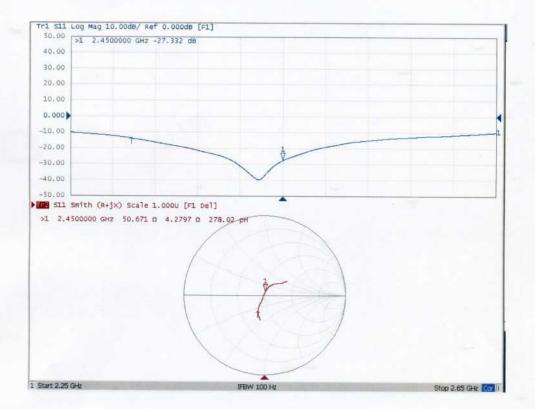


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Impedance Measurement Plot for Body TSL



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Calibration Laboratory of Schmid & Partner **Engineering AG** sstrasse 43, 8004 Zurich, Switzerland

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Accreditation No.: SCS 0108

Accredited by the Swiss Accreditation Service (SAS) The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

Glossary:

TSL ConvF N/A

tissue simulating liquid sensitivity in TSL / NORM x.y.z not applicable or not measured

Calibration is Performed According to the Following Standards:

- a) IEEE Std 1528-2013, "IEEE Recommended Practice for Determining the Peak Spatial-Averaged Specific Absorption Rate (SAR) in the Human Head from Wireless Communications Devices: Measurement Techniques", June 2013
- b) IEC 62209-2, "Procedure to determine the Specific Absorption Rate (SAR) for wireless communication devices used in close proximity to the human body (frequency range of 30 MHz to 6 GHz)", March 2010
- c) KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Additional Documentation:

d) DASY4/5 System Handbook

Methods Applied and Interpretation of Parameters:

- Measurement Conditions: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- Antenna Parameters with TSL: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- Feed Point Impedance and Return Loss: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- Electrical Delay: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- SAR measured: SAR measured at the stated antenna input power.
- SAR normalized: SAR as measured, normalized to an input power of 1 W at the antenna connector
- SAR for nominal TSL parameters: The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Certificate No: D5GHzV2-1160. Oct11

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Measurement Conditions

DASY system configuration, as far as not given on p

DASY Version	DASY5	V52.8.8
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom V5.0	
Distance Dipole Center - TSL	10 mm	with Spacer
Zoom Scan Resolution	dx, dy = 4.0 mm, dz = 1.4 mm	Graded Ratio = 1.4 (Z direction)
Frequency	5200 MHz ± 1 MHz 5300 MHz ± 1 MHz 5600 MHz ± 1 MHz 5800 MHz ± 1 MHz	

Head TSL parameters at 5200 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	36.0	4.66 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	36.4 ± 6 %	4.57 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL at 5200 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	100 mW input power	8.06 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	80.7 W/kg ± 19.9 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR measured	100 mW input power	2.31 W/kg
CAD for nominal Head TCL normators	Wit at her limit	23.1 W/ka + 19.5 % /k-2)

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Head TSL parameters at 5300 MHz

he following parameters and calculations were applied.			
	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.9	4.76 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) °C	36.2 ± 6 %	4.68 mho/m ± 6.%
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL at 5300 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	100 mW input power	8.26 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	82.7 W / kg ± 19.9 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR averaged over 10 cm ³ (10 g) of Head TSL SAR measured	condition 100 mW input power	2.39 W/kg

Head TSL parameters at 5600 MHz

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.5	5.07 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) "C	35.7 ± 6 %	5.03 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL at 5600 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	100 mW input power	8.69 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	87.0 W/kg ± 19.9 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
	the state of the s	0.17.14/0
SAR measured	100 mW input power	2.47 W/kg

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Head TSL parameters at 5800 MHz

	Temperature	Permittivity	Conductivity
Nominal Head TSL parameters	22.0 °C	35.3	5.27 mho/m
Measured Head TSL parameters	(22.0 ± 0.2) "C	35.3 ± 6 %	5.26 mho/m ± 6 %
Head TSL temperature change during test	< 0.5 °C		

SAR result with Head TSL at 5800 MHz

SAR averaged over 1 cm ³ (1 g) of Head TSL	Condition	
SAR measured	100 mW input power	8.20 W/kg
SAR for nominal Head TSL parameters	normalized to 1W	82.0 W/kg ± 19.9 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Head TSL	condition	
SAR averaged over 10 cm ³ (10 g) of Head TSL SAR measured	condition 100 mW input power	2.31 W/kg

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Body TSL parameters at 5200 MHz

te tonowing parameters and calculations were appli	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	49.0	5,30 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) "C	47.9 ± 6 %	5.35 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C		

SAR result with Body TSL at 5200 MHz

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	100 mW input power	7.81 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	77.8 W/kg ± 19.9 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR averaged over 10 cm ³ (10 g) of Body TSL SAR measured	condition 100 mW input power	2.18 W/kg

Body TSL parameters at 5300 MHz

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	48.9	5.42 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	47.7 ± 6 %	5.49 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C		

SAR result with Body TSL at 5300 MHz

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	100 mW input power	7.88 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	78.4 W/kg ± 19.9 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	

SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR measured	100 mW input power	2.20 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	21.9 W/kg ± 19.5 % (k=2)

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Body TSL parameters at 5600 MHz

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	48.5	5.77 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) "C	46.7 ± 6 %	5.99 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C		

SAR result with Body TSL at 5600 MHz

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	100 mW input power	8,20 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	81.5 W/kg ± 19.9 % (k=2)
SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR averaged over 10 cm ³ (10 g) of Body TSL SAR measured	condition 100 mW input power	2.30 W/kg

Body TSL parameters at 5800 MHz

	Temperature	Permittivity	Conductivity
Nominal Body TSL parameters	22.0 °C	48.2	6.00 mho/m
Measured Body TSL parameters	(22.0 ± 0.2) °C	46.4 ± 6 %	6.27 mho/m ± 6 %
Body TSL temperature change during test	< 0.5 °C		

SAR result with Body TSL at 5800 MHz

SAR averaged over 1 cm ³ (1 g) of Body TSL	Condition	
SAR measured	100 mW input power	7.88 W/kg
SAR for nominal Body TSL parameters	normalized to 1W	78.3 W/kg ± 19.9 % (k=2)
The second		
SAR averaged over 10 cm ³ (10 g) of Body TSL	condition	
SAR averaged over 10 cm ² (10 g) of Body TSL SAR measured	100 mW input power	2.20 W/kg

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Appendix (Additional assessments outside the scope of SCS 0108)

Antenna Parameters with Head TSL at 5200 MHz

Impedance, transformed to feed point	48.1 Ω - 8.5 jΩ
Return Loss	- 21.0 dB

Antenna Parameters with Head TSL at 5300 MHz

Impedance, transformed to feed point	50.2 Ω - 5.2 jΩ
Return Loss	- 25.7 dB

Antenna Parameters with Head TSL at 5600 MHz

Impedance, transformed to feed point	54.8 Ω - 2.5 jΩ
Return Loss	- 25.7 dB

Antenna Parameters with Head TSL at 5800 MHz

Impedance, transformed to feed point	53.0 Ω - 3.0 μΩ
Return Loss	- 27.7 dB

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Antenna Parameters with Body TSL at 5200 MHz

Impedance, transformed to feed point	48.6 Ω - 6.8 jΩ
Return Loss	+ 23.0 dB

Antenna Parameters with Body TSL at 5300 MHz

Impedance, transformed to feed point	49.0 Ω - 4.2 jΩ
Return Loss	- 27.1 dB

Antenna Parameters with Body TSL at 5600 MHz

Impedance, transformed to feed point	56.2 Ω - 0.7 jΩ
Return Loss	- 24.6 dB

Antenna Parameters with Body TSL at 5800 MHz

Impedance, transformed to feed point	55.9 Ω - 1.7 jΩ
Return Loss	- 24.8 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.199 ns

After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured.

The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard.

No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
Manufactured on	June 06, 2013

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DASY5 Validation Report for Head TSL

Date: 24.09.2021

Test Laboratory; SPEAG, Zurich, Switzerland

DUT: Dipole 5GHz; Type: D5GHzV2; Serial: D5GHzV2 - SN: 1160

Communication System: UID 0 - CW; Frequency: 5200 MHz, Frequency: 5300 MHz, Frequency: 5600 MHz, Frequency: 5800 MHz

Medium parameters used: f = 5200 MHz; σ = 4.57 S/m; ϵ_r = 36.4; ρ = 1000 kg/m³, Medium parameters used: f = 5300 MHz; σ = 4.68 S/m; ϵ_r = 36.2; ρ = 1000 kg/m³, Medium parameters used: f = 5600 MHz; σ = 5.03 S/m; ϵ_r = 35.7; ρ = 1000 kg/m³, Medium parameters used: f = 5800 MHz; σ = 5.26 S/m; ϵ_r = 35.3; ρ = 1000 kg/m³

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: EX3DV4 SN3503; ConvF(5.51, 5.51, 5.51); Calibrated: 30.12.2021, ConvF(5.21, 5.21, 5.21); Calibrated: 30.12.2021, ConvF(4.92, 4.92, 4.92); Calibrated: 30.12.2021, ConvF(4.9, 4.9, 4.9); Calibrated: 30.12.2021,
- Sensor-Surface: 1,4mm (Mechanical Surface Detection)
- · Electronics: DAE4 Sn601; Calibrated: 17.08.2021
- · Phantom: Flat Phantom 5.0 (front); Type: QD000P50AA; Serial: 1001
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Dipole Calibration for Head Tissue/Pin=100mW, dist=10mm, f=5200 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1,4mm Reference Value = 64.41 V/m; Power Drift = 0.08 dB Peak SAR (extrapolated) = 29.3 W/kg SAR(1 g) = 8.06 W/kg; SAR(10 g) = 2.31 W/kg Maximum value of SAR (measured) = 18.7 W/kg

Dipole Calibration for Head Tissue/Pin=100mW, dist=10mm, f=5300 MHz/Zoom Scan. dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1,4mm Reference Value = 65.31 V/m; Power Drift = 0.05 dB Peak SAR (extrapolated) = 31.1 W/kg SAR(1 g) = 8.26 W/kg; SAR(10 g) = 2.39 W/kg Maximum value of SAR (measured) = 19.4 W/kg

Dipole Calibration for Head Tissue/Pin=100mW, dist=10mm, f=5600 MHz/Zoom Scan,

dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 65.34 V/m; Power Drift = 0.03 dB Peak SAR (extrapolated) = 34.7 W/kg SAR(1 g) = 8.69 W/kg; SAR(10 g) = 2.47 W/kg Maximum value of SAR (measured) = 21.0 W/kg

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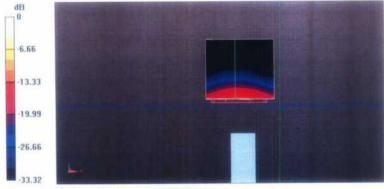
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Dipole Calibration for Head Tissue/Pin=100mW, dist=10mm, f=5800 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 62.41 V/m; Power Drift = 0.03 dB Peak SAR (extrapolated) = 34.5 W/kg SAR(1 g) = 8.2 W/kg; SAR(10 g) = 2.31 W/kg Maximum value of SAR (measured) = 20.5 W/kg



0 dB = 18.7 W/kg = 12.72 dBW/kg

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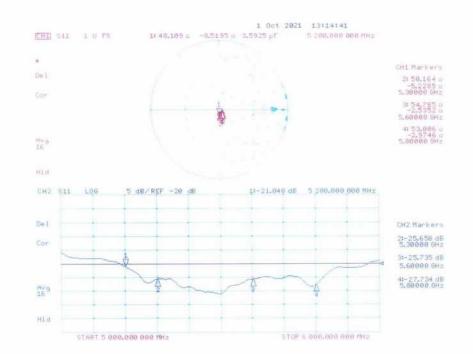
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Impedance Measurement Plot for Head TSL



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DASY5 Validation Report for Body TSL

Date; 05.10.2021

Test Laboratory: SPEAG, Zurich, Switzerland

DUT: Dipole 5GHz; Type: D5GHzV2; Serial: D5GHzV2 - SN: 1160

Communication System: UID 0 - CW; Frequency: 5200 MHz, Frequency: 5300 MHz, Frequency: 5600 MHz, Frequency: 5800 MHz

Medium parameters used: f = 5200 MHz; $\sigma = 5.35 \text{ S/m}$; $\varepsilon_r = 47.9$; $\rho = 1000 \text{ kg/m}^3$. Medium parameters used: f = 5300 MHz; $\sigma = 5.49 \text{ S/m}$; $\varepsilon_r = 47.7$; $\rho = 1000 \text{ kg/m}^3$, Medium parameters used: f = 5600 MHz; $\sigma = 5.99 \text{ S/m}$; $\varepsilon_r = 46.7$; $\rho = 1000 \text{ kg/m}^3$, Medium parameters used: f = 5800 MHz; $\sigma = 6.27 \text{ S/m}$; $\varepsilon_r = 46.4$; $\rho = 1000 \text{ kg/m}^3$

Phantom section: Flat Section

Measurement Standard: DASY5 (IEEE/IEC/ANSI C63.19-2011)

DASY52 Configuration:

- Probe: EX3DV4 SN3503; ConvF(4.95, 4.95, 4.95); Calibrated: 30.12.2021, ConvF(4.78, 4.78, 4.78); Calibrated: 30.12.2021; ConvF(4.35, 4.35, 4.35); Calibrated: 30.12.2021, ConvF(4.32, 4.32, 4.32); Calibrated: 30.12.2021;
- Sensor-Surface: 1.4mm (Mechanical Surface Detection)
- · Electronics: DAE4 Sn601; Calibrated: 17.08.2021
- Phantom: Flat Phantom 5.0 (back): Type: QD000P50AA; Serial: 1002
- DASY52 52.8.8(1222); SEMCAD X 14.6.10(7331)

Dipole Calibration for Body Tissue/Pin=100mW, dist=10mm, f=5200 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid; dx=4mm, dy=4mm, dz=1.4mm Reference Value = 67.32 V/m; Power Drift = -0.04 dB Peak SAR (extrapolated) = 30.4 W/kg SAR(1 g) = 7.81 W/kg; SAR(10 g) = 2.18 W/kg Maximum value of SAR (measured) = 18.2 W/kg

Dipole Calibration for Body Tissue/Pin=100mW, dist=10mm, f=5300 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 67.22 V/m; Power Drift = -0.06 dB Peak SAR (extrapolated) = 31.6 W/kg SAR(1 g) = 7.88 W/kg; SAR(10 g) = 2.2 W/kg Maximum value of SAR (measured) = 18.8 W/kg

Dipole Calibration for Body Tissue/Pin=100mW, dist=10mm, f=5600 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 67,36 V/m; Power Drift = -0.03 dB Peak SAR (extrapolated) = 36.6 W/kg SAR(1 g) = 8.2 W/kg; SAR(10 g) = 2.3 W/kg Maximum value of SAR (measured) = 20.2 W/kg

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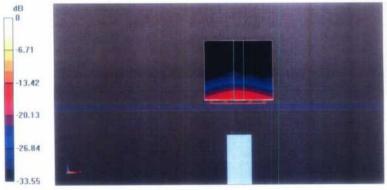
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Dipole Calibration for Body Tissue/Pin=100mW, dist=10mm, f=5800 MHz/Zoom Scan, dist=1.4mm (8x8x7)/Cube 0: Measurement grid: dx=4mm, dy=4mm, dz=1.4mm Reference Value = 65.22 V/m; Power Drift = -0.03 dB Peak SAR (extrapolated) = 37.1 W/kg SAR(1 g) = 7.88 W/kg; SAR(10 g) = 2.2 W/kg Maximum value of SAR (measured) = 19.7 W/kg



0 dB = 18.2 W/kg = 12.60 dBW/kg

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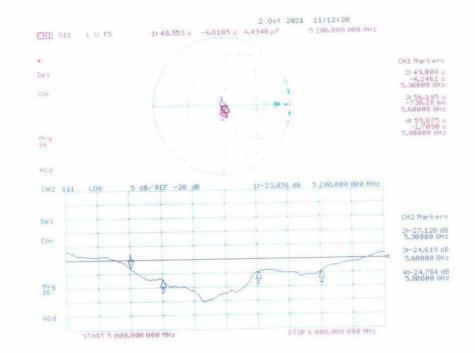
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Impedance Measurement Plot for Body TSL



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*****END OF REPORT*****

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